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Burn-in & Test Strategies Workshop

www.bitsworkshop.org

Summary

Learn...

Tutorial, Distinguished Speaker, Keynote, 29 Papers, 5 Posters
> 850 PowerPoint slides

Explore...

- BiTS EXPO: 46 Exhibitors (48 Booths)

Share...

- Meals, Networking, Casino Night

What's NOW & NEXT in Test & Burn-in of Packaged ICs



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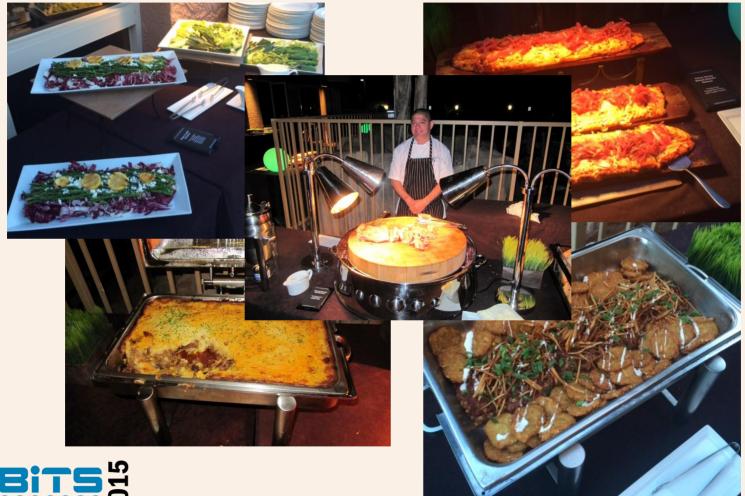


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Fantastic St. Patrick's Day Food!





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... and did we mention beer & stout?





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Happy Prize Winners



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Casino Night Prize Winners

- Waterproof USB speaker
 - Tom Sutton, Sensata
 - Jonathan Lee, SRC
- Google Chromecast
 - Bill Wyckoff, Teradyne
 - Jack Pereschuk, Phoenix Test Arrays
- Bose Headphones
 - Chet Reshamwala, Sensata
- Samsung Galaxy Tab4
 - Khaled Elmadbouly, Smiths Connectors



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Have the LAST WORD! Overall Workshop Evaluation

Technical Program Exhibits Facilities Meals/Social Activities Registration Process Overall Evaluation			Fair	Poor	
Do You WANT TO ATTEND BITS 2016?			Yes	No	
ლ სე					



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- In Person
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 - Audio with synchronized slides & pointer
 - BiTS 2013 & BiTS 2014
 - BiTS 2015 posted shortly after BiTS
- Additional content
 - Tutorials
- Subscription Model
 - BiTS 2015 Professional Attendees Subscription for One Year
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March 6-9, 2016 + Mesa, Arizona

Presentations • Posters • Tutorial

Share your latest work and advancements as an **AUTHOR**! Your presentation or poster will be part of a stimulating and comprehensive program. Explore a demanding topic as a **TUTORIAL INSTRUCTOR**. Share your expertise with participants eager to build their leading edge skills. Presentation, Poster & Tutorial proposals addressing a broad range of burn-in and test subjects are welcome, including, but not limited to:

- Socketing/Contacting of Contemporary and Advanced Packaging Technologies
- PCBs, Materials, Handlers, Contact
- Technologies, Burn-in Tooling
- Modeling, Characterization & Analysis
- Process & Operational Challenges
- WLCSP Test for KGD or Final Test
- MEMS and Non-Electrical Stimuli Test

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For more information about BiTS 2016 please contact the BITS Office <u>bitsinfo@bitsworkshop.org</u>



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Authors	Company
Justin Yun, BoHyun Kim	TSE Co., Ltd.
Mike Gedeon	Materion
JD Cho, AJ Park	IWIN Co. Ltd.
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BiTS Awards

- Best Presentation
- Best Poster
- Best Data Presented
- Most Inspirational Presentation
- Best Presentation, Tutorial in Nature
- Attendee Choice
- ... and ...



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BiTS "Special" Award

For the Least Concealed Sales Pitch





Will remain "semi-retired" for now...



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March 6 – 9 , 2016 Hilton Phoenix / Mesa Hotel



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